

Search Notes**Application/Control No.**

10/695,803

Examiner

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Applicant(s)/Patent under Reexamination

SARWARY ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	6	2/3/2006	JSL
716	1	2/3/2006	JSL
716	4	2/3/2006	JSL
716	5	2/3/2006	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	2/3/2006	JSL
IEEE	2/3/2006	JSL
GOOGLE	2/3/2006	JSL

INTERFERENCE SEARCHED

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716	6	2/3/2006	JSL
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